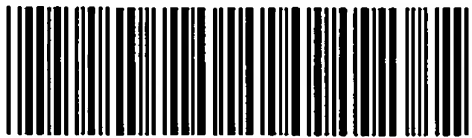


Search Notes

Application/Control No.

10/729,993

Examiner

Brian Young

Applicant(s)/Patent under
Reexamination

HAN ET AL.

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
341	106	5/27/2005	BY
J	107	J	BY
	50		BY
	51		BY
	55		BY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
341	106	5/27/2005	BY
341	50	//	BY

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (jpo,epo.etc.) NPL (IEEE, Portal)	5/27/2005	BY